


<b>Search Notes</b> 	<b>Application/Control No.</b> 10670523	<b>Applicant(s)/Patent Under Reexamination</b> IBUKA ET AL.
	<b>Examiner</b> TAN X DINH	<b>Art Unit</b> 2627

SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES		
Search Notes	Date	Examiner
Updated EAST (see search history printout)	10/10/08	
Updated EAST (see search history printout)	3/15/09	T.D

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference Search History Printout		3/15/09	T.D

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